

GSM4599C

60V N & P Pair Enhancement Mode MOSFET

Product Description

These miniature surface mount MOSFETs utilize High Cell Density process. Low $R_{DS(ON)}$ assures minimal power loss and conserves energy, making this device ideal for use in power management circuitry.

Typical applications are PWM DC-DC converters, power management in portable and battery powered products such as computers, printers, battery charger, telecommunication power system, and telephones power system.

Features

N-Channel

- 60V, 4.5A, $R_{DS(ON)}=58m\Omega@V_{GS}=10V$
- 60V, 4.0A, $R_{DS(ON)}=85m\Omega@V_{GS}=4.5V$

P-Channel

- -60V, -3.5A, $R_{DS(ON)}=90m\Omega@V_{GS}=-10V$
- -60V, -3.0A, $R_{DS(ON)}=135m\Omega@V_{GS}=-4.5V$
- Fast switching speed
- SOP-8 package design

Applications

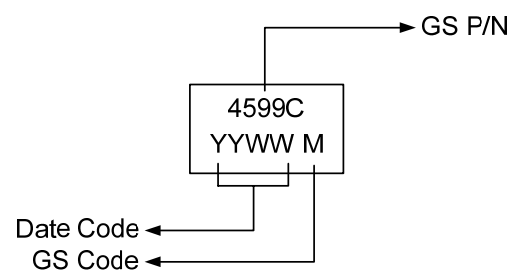
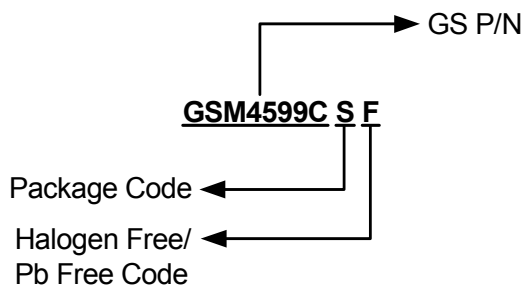
- Power Management in Note
- Portable Equipment / LCD Display inverter
- Battery Powered System / Load Switch

Packages & Pin Assignments

GSM4599CSF (SOP-8)

Pin	Description	Pin	Description
1	Source1	5	Drain2
2	Gate1	6	Drain2
3	Source2	7	Drain1
4	Gate2	8	Drain1

Ordering & Marking Information



Part Number	Package	Quantity Reel
GSM4599CSF	SOP-8	4000 PCS

Absolute Maximum Ratings (N-Channel)

($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Typical	Unit
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current (*1)	$T_A=25^\circ\text{C}$	4.5
		$T_A=70^\circ\text{C}$	4
I_{DM}	Pulsed Drain Current (*2)	20	A
I_S	Continuous Source Current (Diode Conduction) (*1)	1.3	A
P_D	Power Dissipation (*1)	$T_A=25^\circ\text{C}$	2
		$T_A=70^\circ\text{C}$	1.3
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient (*1)	62.5	$^\circ\text{C}/\text{W}$

Note 1: Surface Mounted on 1" x 1" FR4 Board.

Note 2: Pulse width limited by maximum junction temperature.

Electrical Characteristics (N-Channel)

($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	60			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1	1.5	2.5	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			± 100	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=48\text{V}, V_{GS}=0\text{V}$			1	μA
$I_{D(on)}$	On-State Drain Current (*3)	$V_{DS} \geq 5\text{V}, V_{GS}=10\text{V}$	20			A
$R_{DS(on)}$	Drain-Source On-Resistance (*3)	$V_{GS}=10\text{V}, I_D=4.5\text{A}$		40	58	m Ω
		$V_{GS}=4.5\text{V}, I_D=4\text{A}$		55	85	
g_{FS}	Forward Transconductance (*3)	$V_{DS}=10\text{V}, I_D=4.5\text{A}$		14		S
Dynamic						
Q_g	Total Gate Charge	$V_{DS}=0.5V_{(BR)DSS}, V_{GS}=10\text{V}, I_D=4.5\text{A}$		12		nC
Q_{GS}	Gate-Source Charge			2.4		
Q_{GD}	Gate-Drain Charge			2.6		
$t_{d(on)}$	Turn-On Time	$V_{DD}=30\text{V}, I_D=1\text{A}, V_{GS}=10\text{V}, R_G=6\Omega$		11		ns
T_r				8		
$t_{d(off)}$	Turn-Off Time			19		
T_f				6		

Note 3: Pulse test: $PW \leq 300\mu\text{sec}$, duty cycle $\leq 2\%$.

Absolute Maximum Ratings (P-Channel)

(T_A=25°C unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DS}	Drain-Source Voltage	-60	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current (*1)	T _A =25°C	-3.5
		T _A =70°C	-3
I _{DM}	Pulsed Drain Current (*2)	-20	A
I _S	Continuous Source Current (Diode Conduction) (*1)	-1.3	A
P _D	Power Dissipation (*1)	T _A =25°C	2
		T _A =70°C	1.3
T _J	Operating Junction Temperature Range	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient (*1)	62.5	°C/W

Note 1: Surface Mounted on 1" x 1" FR4 Board.

Note 2: Pulse width limited by maximum junction temperature.

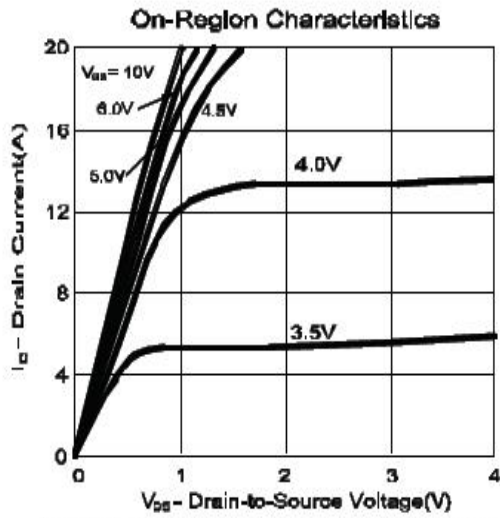
Electrical Characteristics (P-Channel)

(T_A=25°C unless otherwise noted)

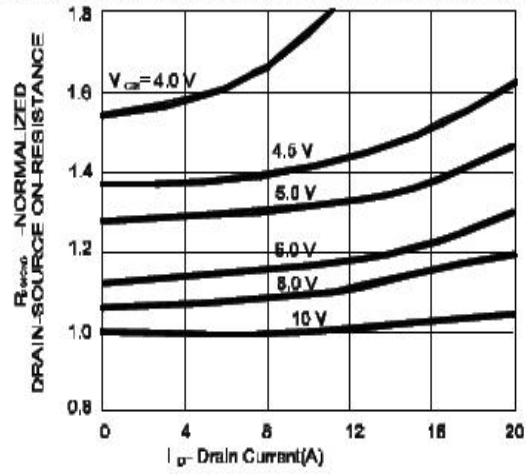
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-60			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1	-1.5	-2.5	
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-48V, V _{GS} =0V			-1	uA
I _{D(on)}	On-State Drain Current (*3)	V _{DS} ≤ -5V, V _{GS} =-10V	-20			A
R _{DS(on)}	Drain-Source On-Resistance (*3)	V _{GS} =-10V, I _D =-3.5A		70	90	mΩ
		V _{GS} =-4.5V, I _D =-3A		100	135	
g _{FS}	Forward Transconductance (*3)	V _{DS} =-5V, I _D =-3.5A		9		S
Dynamic						
Q _g	Total Gate Charge	V _{DS} =-0.5V _{(BR)DSS} , V _{GS} =-10V, I _D =-3.5A		11		nC
Q _{gs}	Gate-Source Charge			2.1		
Q _{gd}	Gate-Drain Charge			2.5		
t _{d(on)}	Turn-On Time	V _{DD} =-30V, I _D =-1A, V _{GS} =-10V, R _G =6Ω		6		ns
T _r				8		
t _{d(off)}	Turn-Off Time			17		
T _f				11		

Note 3: Pulse test: PW ≤ 300usec, duty cycle ≤ 2%.

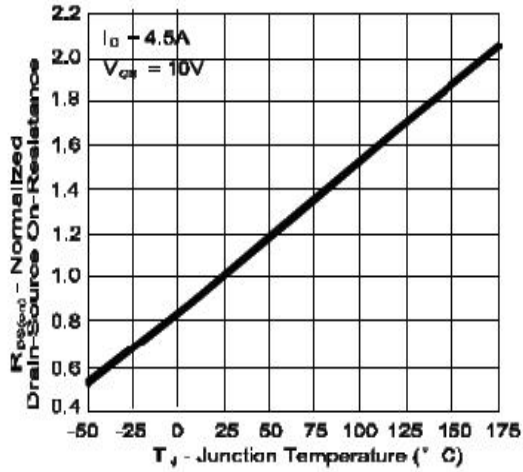
Typical Performance Characteristics (N-Channel)



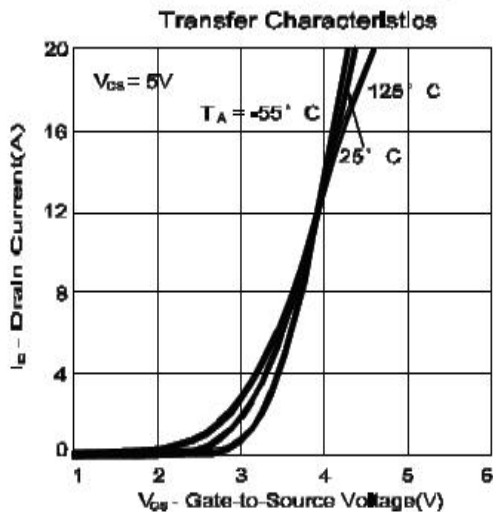
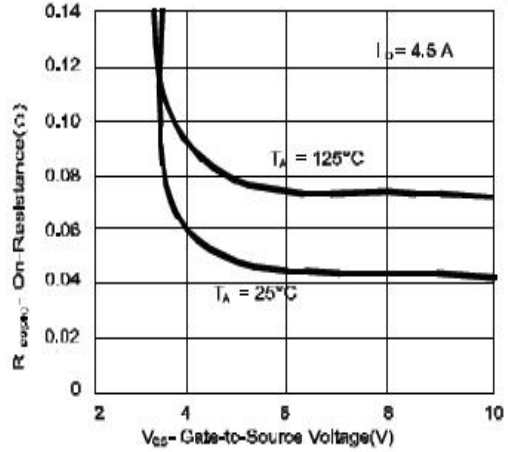
On-Resistance Variation with Drain Current and Gate Voltage



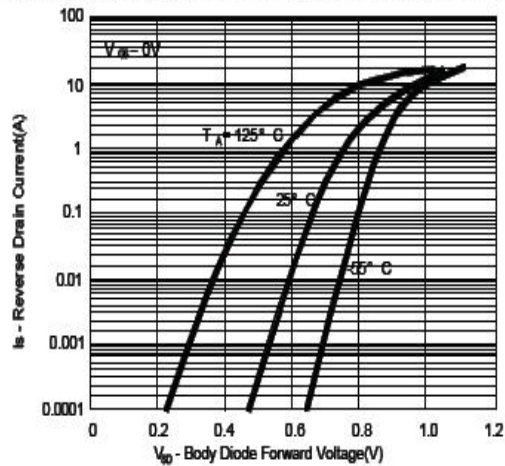
On-Resistance Variation with Temperature



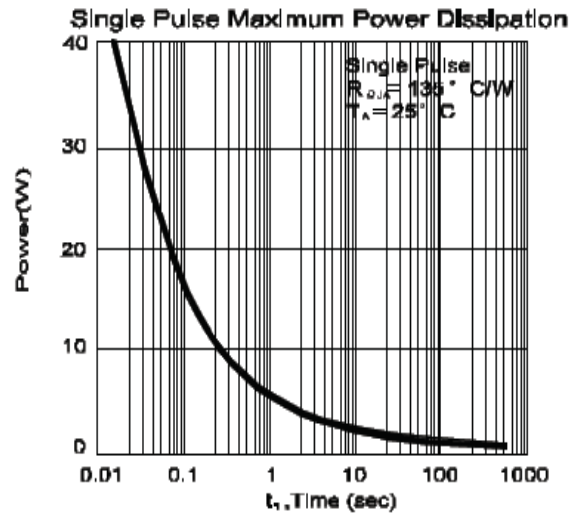
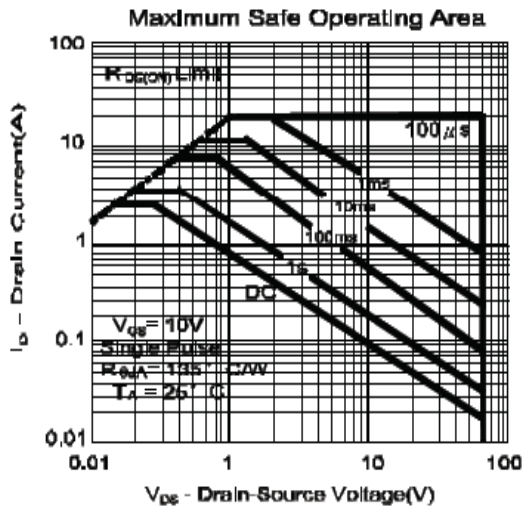
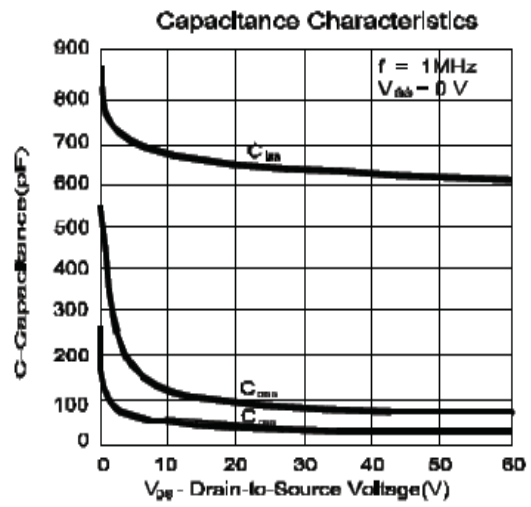
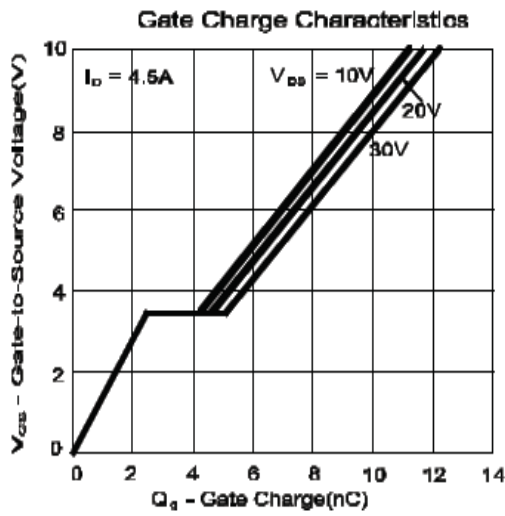
On-Resistance Variation with Gate-to-Source Voltage



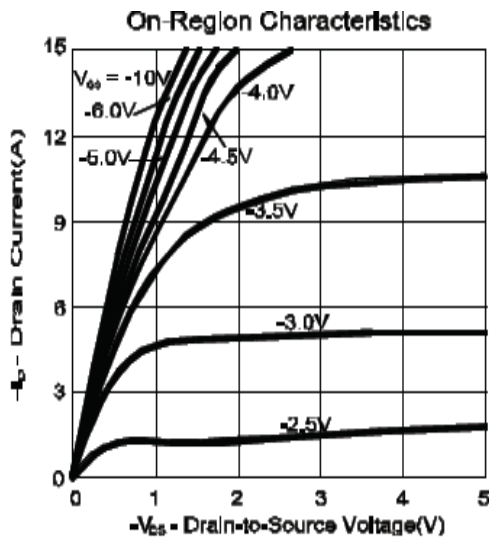
Body Diode Forward Voltage Variation with Source Current and Temperature



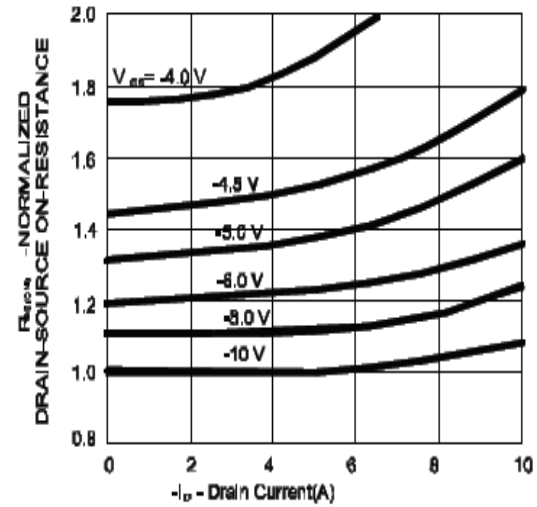
Typical Performance Characteristics (N-Channel)



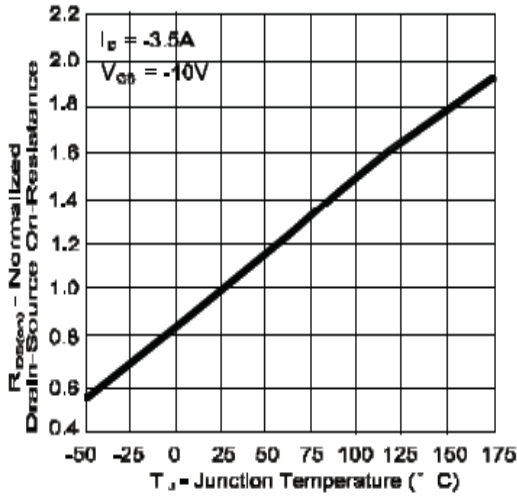
Typical Performance Characteristics (P-Channel)



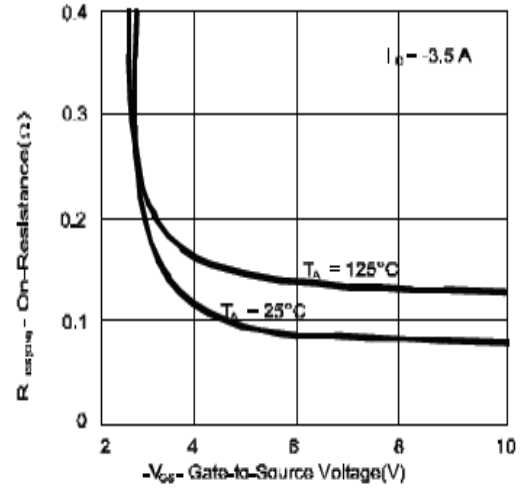
On-Resistance Variation with Drain Current and Gate Voltage



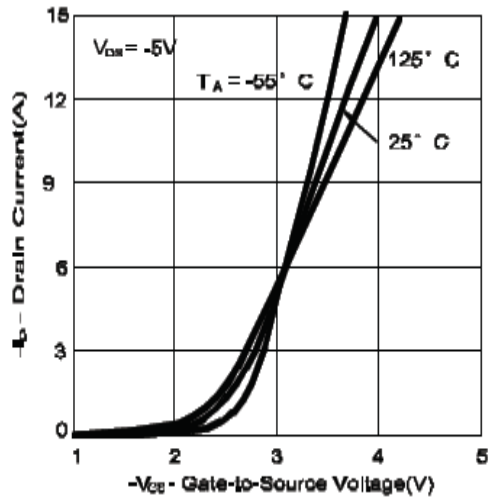
On-Resistance Variation with Temperature



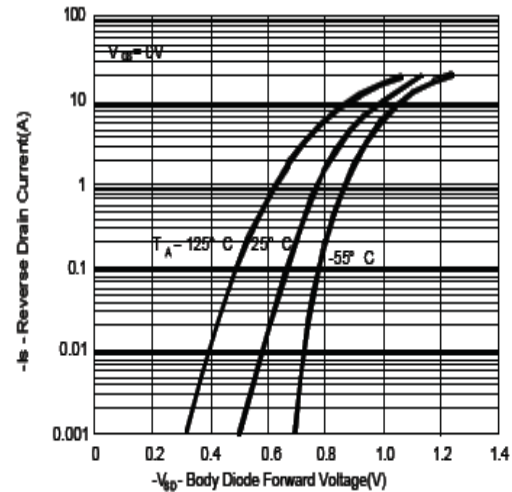
On-Resistance Variation with Gate-to-Source Voltage



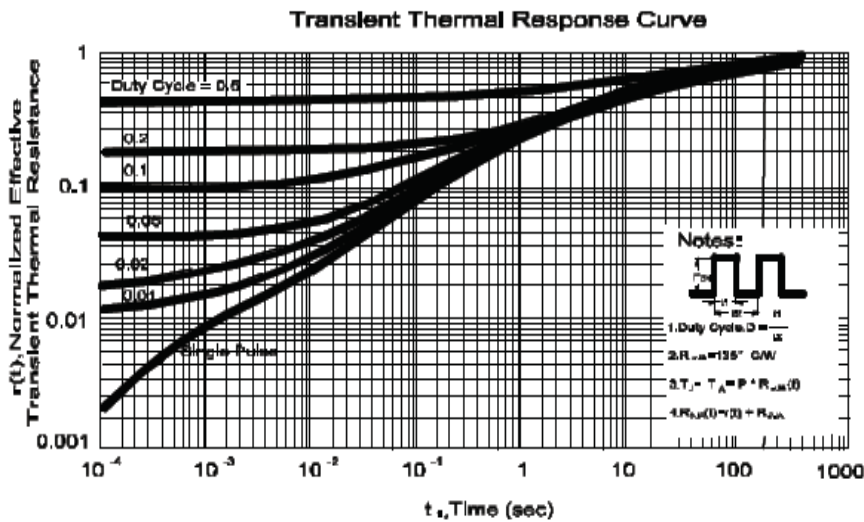
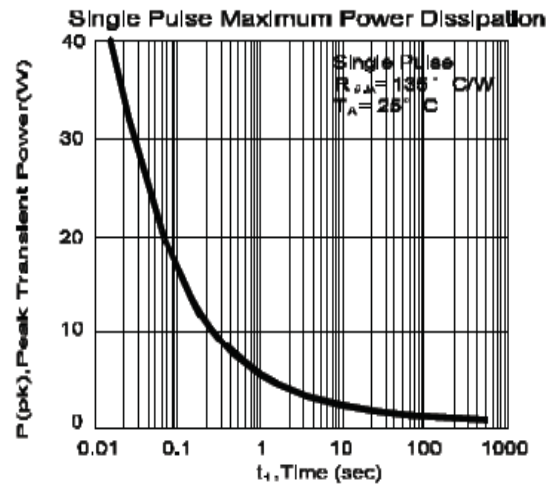
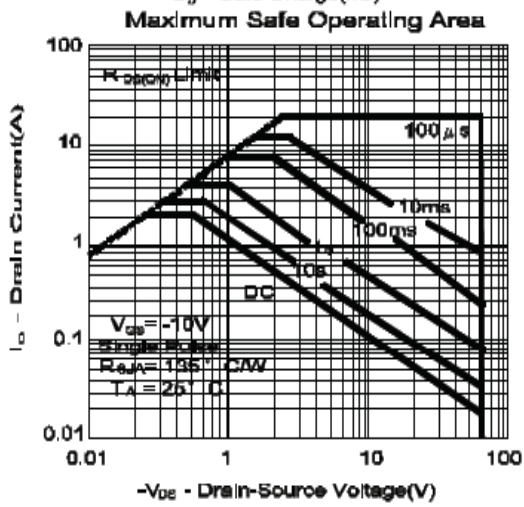
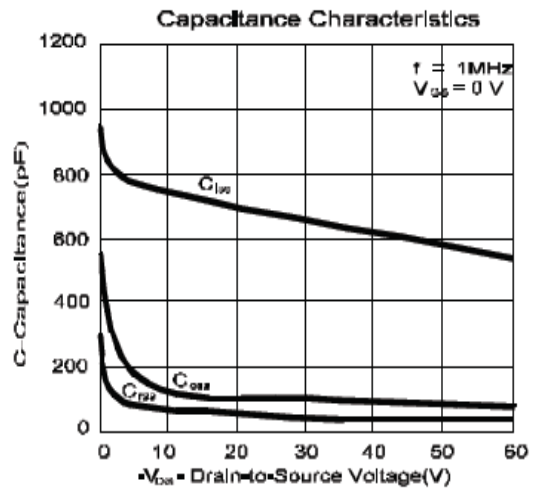
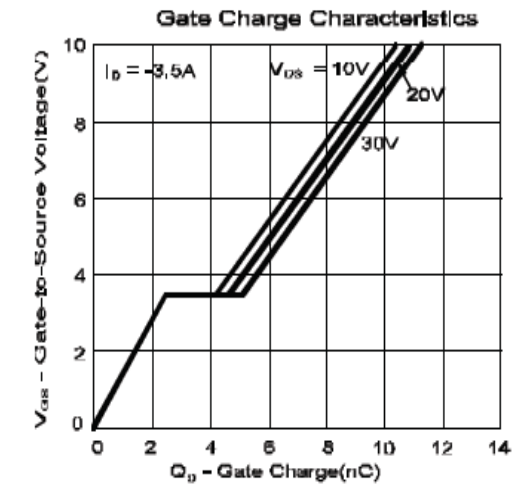
Transfer Characteristics



Body Diode Forward Voltage Variation with Source Current and Temperature

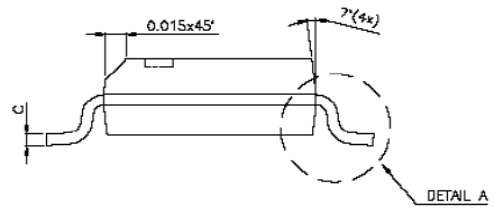
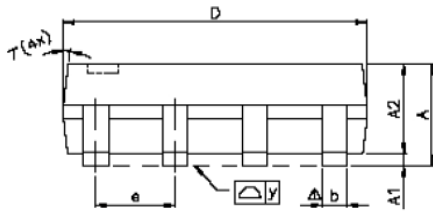
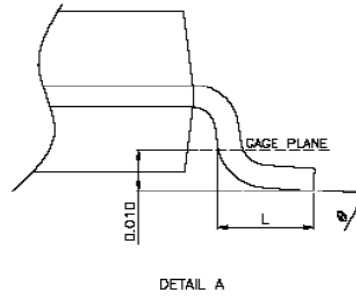
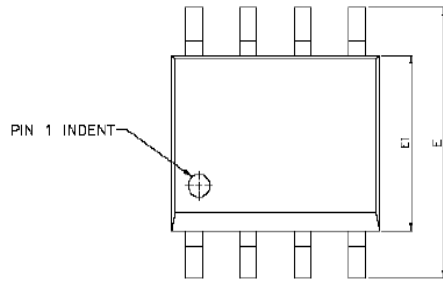


Typical Performance Characteristics (P-Channel)



Package Dimension

SOP-8










Dimensions						
SYMBOL	Millimeters			Inches		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.47	1.60	1.73	0.058	0.063	0.068
A1	0.10	-	0.25	0.004	-	0.010
A2	-	1.45	-	-	0.057	-
b	0.33	0.41	0.51	0.013	0.016	0.020
C	0.19	0.20	0.25	0.0075	0.008	0.0098
D	4.80	4.85	4.95	0.189	0.191	0.195
E	5.80	6.00	6.20	0.228	0.236	0.244
E1	3.80	3.90	4.00	0.150	0.154	0.157
e	-	1.27	-	-	0.050	-
L	0.38	0.71	1.27	0.015	0.028	0.050
Δy	-	-	0.076	-	-	0.003
θ	0°	-	8°	0°	-	8°



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